# **Ignition IGBT**

## 20 Amp, 350 Volt, N-Channel DPAK

This Logic Level Insulated Gate Bipolar Transistor (IGBT) features monolithic circuitry integrating ESD and Overvoltage clamped protection for use in inductive coil drivers applications. Primary uses include Ignition, Direct Fuel Injection, or wherever high voltage and high current switching is required.

#### **Features**

- Ideal for Coil-on-Plug and Driver-on-Coil Applications
- DPAK Package Offers Smaller Footprint for Increased Board Space
- Gate-Emitter ESD Protection
- Temperature Compensated Gate-Collector Voltage Clamp Limits Stress Applied to Load
- Integrated ESD Diode Protection
- Low Threshold Voltage for Interfacing Power Loads to Logic or Microprocessor Devices
- Low Saturation Voltage
- High Pulsed Current Capability
- Optional Gate Resistor (R<sub>G</sub>) and Gate-Emitter Resistor (R<sub>GE</sub>)
- Pb-Free Package is Available

#### **Applications**

• Ignition Systems

#### MAXIMUM RATINGS (T<sub>.I</sub> = 25°C unless otherwise noted)

Rating	Symbol	Value	Unit
Collector-Emitter Voltage	V <sub>CES</sub>	390	V
Collector-Gate Voltage	V <sub>CER</sub>	390	V
Gate-Emitter Voltage	$V_{GE}$	±15	>
Collector Current–Continuous @ T <sub>C</sub> = 25°C – Pulsed	I <sub>C</sub>	20 50	A <sub>DC</sub> A <sub>AC</sub>
Continuous Gate Current	I <sub>G</sub>	1.0	mA
Transient Gate Current (t≤2 ms, f≤100 Hz)	I <sub>G</sub>	20	mA
ESD (Charged-Device Model)	ESD	2.0	kV
ESD (Human Body Model) R = 1500 $\Omega$ , C = 100 pF	ESD	8.0	kV
ESD (Machine Model) R = 0 $\Omega$ , C = 200 pF	ESD	500	V
Total Power Dissipation @ T <sub>C</sub> = 25°C Derate above 25°C	P <sub>D</sub>	125 0.83	W W/°C
Operating & Storage Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-55 to +175	°C

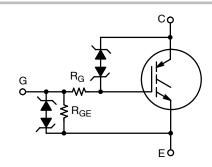
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



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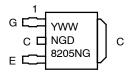
20 A, 350 V V<sub>CE(on)</sub> = 1.3 V @ I<sub>C</sub> = 10 A, V<sub>GE</sub> ≥ 4.5 V





DPAK CASE 369C STYLE 7

#### **MARKING DIAGRAM**



Y = Year
WW = Work Week
NGD8205N = Device Code
G = Pb-Free Package

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NGD8205NT4	DPAK	2500 / Tape & Reel
NGD8205NT4G	DPAK (Pb-Free)	2500 / Tape & Reel

†For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

#### UNCLAMPED COLLECTOR-TO-EMITTER AVALANCHE CHARACTERISTICS ( $-55^{\circ} \le T_J \le 175^{\circ}C$ )

Characteristic	Symbol	Value	Unit
Single Pulse Collector–to–Emitter Avalanche Energy $V_{CC} = 50 \text{ V, } V_{GE} = 5.0 \text{ V, Pk } I_L = 16.7 \text{ A, } R_G = 1000 \ \Omega, \ L = 1.8 \text{ mH, Starting } T_J = 25^{\circ}\text{C}$ $V_{CC} = 50 \text{ V, } V_{GE} = 5.0 \text{ V, Pk } I_L = 14.9 \text{ A, } R_G = 1000 \ \Omega, \ L = 1.8 \text{ mH, Starting } T_J = 150^{\circ}\text{C}$ $V_{CC} = 50 \text{ V, } V_{GE} = 5.0 \text{ V, Pk } I_L = 14.1 \text{ A, } R_G = 1000 \ \Omega, \ L = 1.8 \text{ mH, Starting } T_J = 175^{\circ}\text{C}$	E <sub>AS</sub>	250 200 180	mJ
Reverse Avalanche Energy $V_{CC}$ = 100 V, $V_{GE}$ = 20 V, Pk I <sub>L</sub> = 25.8 A, L = 6.0 mH, Starting T <sub>J</sub> = 25°C	E <sub>AS(R)</sub>	2000	mJ

#### THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Case	$R_{ heta JC}$	1.2	°C/W
Thermal Resistance, Junction-to-Ambient (Note 1)	$R_{ hetaJA}$	95	°C/W
Maximum Temperature for Soldering Purposes, 1/8" from case for 5 seconds (Note 2)	T <sub>L</sub>	275	°C

#### **ELECTRICAL CHARACTERISTICS**

Characteristic	Symbol	Test Conditions	Temperature	Min	Тур	Max	Unit
OFF CHARACTERISTICS	•			•		•	•
Collector-Emitter Clamp Voltage	BV <sub>CES</sub>	I <sub>C</sub> = 2.0 mA	$T_{J} = -40^{\circ}\text{C to } 175^{\circ}\text{C}$	325	350	375	V
		I <sub>C</sub> = 10 mA	$T_{J} = -40^{\circ}\text{C to } 175^{\circ}\text{C}$	340	365	390	
Zero Gate Voltage Collector Current	I <sub>CES</sub>	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 15 V	T <sub>J</sub> = 25°C		0.1	1.0	μΑ
			T <sub>J</sub> = 25°C	0.5	1.5	10	μΑ
		V <sub>CE</sub> = 175 V, V <sub>GE</sub> = 0 V	T <sub>J</sub> = 175°C	1.0	25	100*	1
		VGE - 0 V	T <sub>J</sub> = -40°C	0.4	0.8	5.0	
Reverse Collector-Emitter Clamp Voltage	B <sub>VCES(R)</sub>		T <sub>J</sub> = 25°C	30	35	39	V
		I <sub>C</sub> = -75 mA	T <sub>J</sub> = 175°C	35	39	45*	1
			T <sub>J</sub> = −40°C	30	33	37	
Reverse Collector-Emitter Leakage Current	I <sub>CES(R)</sub>		T <sub>J</sub> = 25°C	0.05	0.25	0.5	mA
		V <sub>CE</sub> = -24 V	T <sub>J</sub> = 175°C	1.0	12.5	25*	
			T <sub>J</sub> = −40°C	0.005	0.03	0.25	
Gate-Emitter Clamp Voltage	BV <sub>GES</sub>	$I_G = \pm 5.0 \text{ mA}$	$T_{J} = -40^{\circ}\text{C to } 175^{\circ}\text{C}$	12	12.5	14	V
Gate-Emitter Leakage Current	I <sub>GES</sub>	$V_{GE} = \pm 5.0 \text{ V}$	$T_{J} = -40^{\circ}\text{C to } 175^{\circ}\text{C}$	200	300	350*	μΑ
Gate Resistor (Optional)	$R_{G}$		$T_J = -40^{\circ}\text{C} \text{ to } 175^{\circ}\text{C}$		70		Ω
Gate-Emitter Resistor	R <sub>GE</sub>		$T_J = -40^{\circ}\text{C} \text{ to } 175^{\circ}\text{C}$	14.25	16	25	kΩ
ON CHARACTERISTICS (Note 4)	•					1	
Gate Threshold Voltage	V <sub>GE(th)</sub>		T <sub>J</sub> = 25°C	1.5	1.8	2.1	V
		I <sub>C</sub> = 1.0 mA, V <sub>GE</sub> = V <sub>CE</sub>	T <sub>J</sub> = 175°C	0.7	1.0	1.3	1
		VGE - VCE	T <sub>J</sub> = -40°C	1.7	2.0	2.3*	1
Threshold Temperature Coefficient (Negative)				3.8	4.6	6.0	mV/°C

<sup>\*</sup>Maximum Value of Characteristic across Temperature Range.

When surface mounted to an FR4 board using the minimum recommended pad size.
 For further details, see Soldering and Mounting Techniques Reference Manual: SOLDERRM/D.

<sup>3.</sup> Pulse Test: Pulse Width  $\leq$  300  $\mu$ S, Duty Cycle  $\leq$  2%.

#### **ELECTRICAL CHARACTERISTICS**

Characteristic	Symbol	Test Conditions	Temperature	Min	Тур	Max	Unit
ON CHARACTERISTICS (Note 4)							
Collector-to-Emitter On-Voltage	V <sub>CE(on)</sub>	I <sub>C</sub> = 6.5 A, V <sub>GE</sub> = 3.7 V	T <sub>J</sub> = 25°C	0.95	1.15	1.35	V
			T <sub>J</sub> = 175°C	0.7	0.95	1.15	
		GE	$T_J = -40^{\circ}C$	1.0	1.3	1.40	
			T <sub>J</sub> = 25°C	0.95	1.25	1.45	
		I <sub>C</sub> = 9.0 A, V <sub>GE</sub> = 3.9 V	T <sub>J</sub> = 175°C	0.8	1.05	1.25	
		I GE SIS I	$T_J = -40^{\circ}C$	1.1	1.4	1.5	
			$T_J = 25^{\circ}C$	0.85	1.15	1.4	
		I <sub>C</sub> = 7.5 A, V <sub>GF</sub> = 4.5 V	T <sub>J</sub> = 175°C	0.7	0.95	1.2	
		I GE	$T_J = -40^{\circ}C$	1.0	1.3	1.6*	
			$T_J = 25^{\circ}C$	1.0	1.3	1.6	
		I <sub>C</sub> = 10 A, V <sub>GE</sub> = 4.5 V	T <sub>J</sub> = 175°C	0.8	1.05	1.4	
		I GE	$T_J = -40^{\circ}C$	1.1	1.4	1.7*	
			T <sub>J</sub> = 25°C	1.15	1.45	1.7	
		I <sub>C</sub> = 15 A, V <sub>GE</sub> = 4.5 V	T <sub>J</sub> = 175°C	1.0	1.3	1.55	
		I GE	$T_J = -40^{\circ}C$	1.25	1.55	1.8*	
			T <sub>J</sub> = 25°C	1.3	1.6	1.9	
		I <sub>C</sub> = 20 A, V <sub>GE</sub> = 4.5 V	T <sub>J</sub> = 175°C	1.2	1.5	1.8	
		I GE	$T_J = -40^{\circ}C$	1.4	1.75	2.0*	
Forward Transconductance	gfs	I <sub>C</sub> = 6.0 A, V <sub>CE</sub> = 5.0 V	T <sub>J</sub> = 25°C	10	18	25	Mhos
DYNAMIC CHARACTERISTICS	ı	l .				l	l
Input Capacitance	C <sub>ISS</sub>			1100	1300	1500	pF
Output Capacitance	C <sub>OSS</sub>	f = 10 kHz, V <sub>CE</sub> = 25 V	T <sub>J</sub> = 25°C	70	80	90	
Transfer Capacitance	C <sub>RSS</sub>	"	· ·	18	20	22	
SWITCHING CHARACTERISTICS							
Turn-Off Delay Time (Resistive)	t <sub>d(off)</sub>		T <sub>J</sub> = 25°C	6.0	8.0	10	μSec
		V <sub>CC</sub> = 300 V, I <sub>C</sub> = 9.0 A	T <sub>J</sub> = 175°C	6.0	8.0	10	
Fall Time (Resistive)	t <sub>f</sub>	$R_G$ = 1.0 kΩ, $R_L$ = 33 Ω, $V_{GE}$ = 5.0 V	T <sub>J</sub> = 25°C	4.0	6.0	8.0	
			T <sub>J</sub> = 175°C	8.0	10.5	14	
Turn-Off Delay Time (Inductive)	t <sub>d(off)</sub>		T <sub>J</sub> = 25°C	3.0	5.0	7.0	
	, ,	V <sub>CC</sub> = 300 V, I <sub>C</sub> = 9.0 A	T <sub>J</sub> = 175°C	5.0	7.0	9.0	
Fall Time (Inductive)	t <sub>f</sub>	$R_G$ = 1.0 kΩ, L = 300 μH, $V_{GE}$ = 5.0 V	T <sub>J</sub> = 25°C	1.5	3.0	4.5	
			T <sub>J</sub> = 175°C	5.0	7.0	10	
Turn-On Delay Time	t <sub>d(on)</sub>		T <sub>J</sub> = 25°C	1.0	1.5	2.0	
	, ,	V <sub>CC</sub> = 14 V, I <sub>C</sub> = 9.0 A	T <sub>J</sub> = 175°C	1.0	1.5	2.0	
Rise Time	t <sub>r</sub>	$R_G$ = 1.0 kΩ, $R_L$ = 1.5 Ω, $V_{GF}$ = 5.0 V	T <sub>J</sub> = 25°C	4.0	6.0	8.0	
		GL -	T <sub>J</sub> = 175°C	3.0	5.0	7.0	
		1	=	1	I.		ı

<sup>\*</sup>Maximum Value of Characteristic across Temperature Range. 4. Pulse Test: Pulse Width  $\leq 300~\mu S$ , Duty Cycle  $\leq 2\%$ .

#### TYPICAL ELECTRICAL CHARACTERISTICS

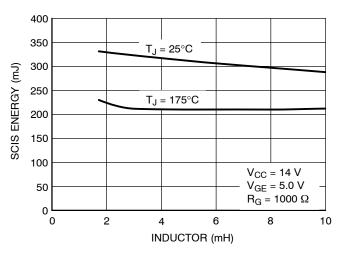


Figure 1. Self Clamped Inductive Switching

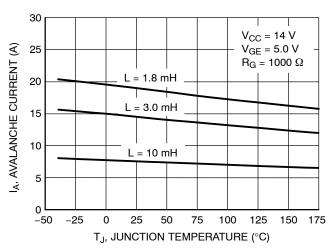


Figure 2. Open Secondary Avalanche Current vs. Temperature

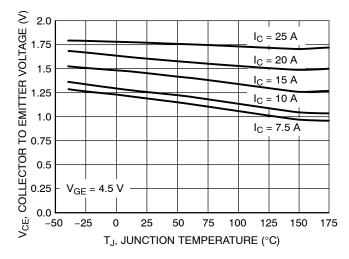


Figure 3. Collector-to-Emitter Voltage vs.
Junction Temperature

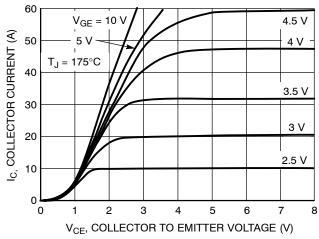


Figure 4. Collector Current vs. Collector-to-Emitter Voltage

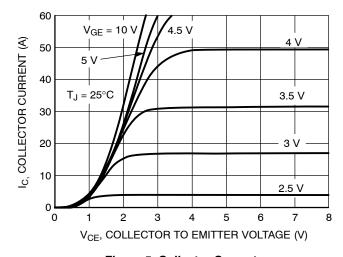


Figure 5. Collector Current vs. Collector-to-Emitter Voltage

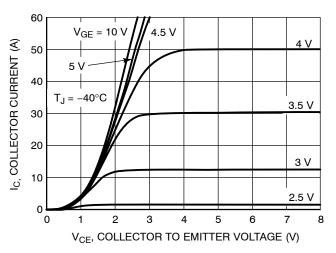


Figure 6. Collector Current vs. Collector-to-Emitter Voltage

#### TYPICAL ELECTRICAL CHARACTERISTICS

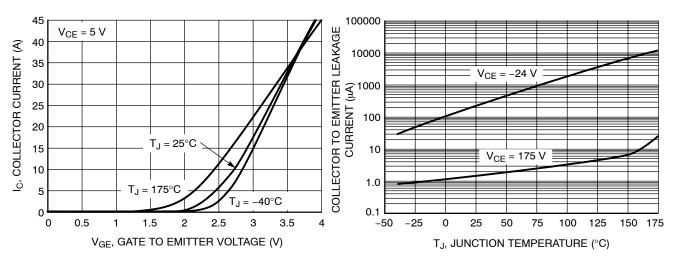


Figure 7. Transfer Characteristics

Figure 8. Collector-to-Emitter Leakage Current vs. Temperature

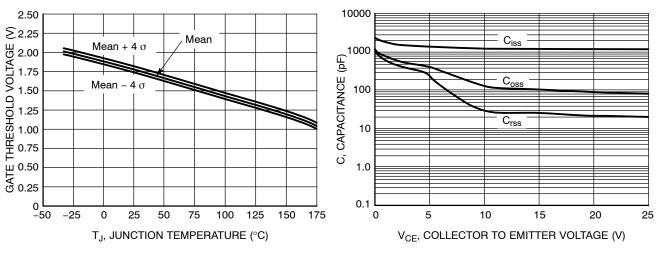


Figure 9. Gate Threshold Voltage vs. Temperature

12 10 t<sub>fall</sub> SWITCHING TIME (µs) t<sub>delay</sub> V<sub>CC</sub> = 300 V  $V_{GE} = 5.0 \text{ V}$  $R_G = 1000 \Omega$  $I_{C} = 9.0 A$  $R_L = 33 \Omega$ 0 25 50 100 125 150 175 T<sub>J</sub>, JUNCTION TEMPERATURE (°C)

Figure 11. Resistive Switching Fall Time vs. Temperature

Figure 10. Capacitance vs. Collector-to-Emitter Voltage

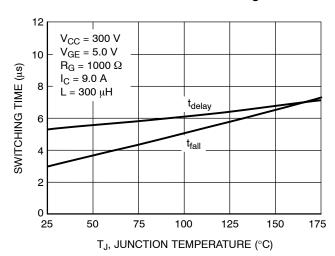


Figure 12. Inductive Switching Fall Time vs.
Temperature

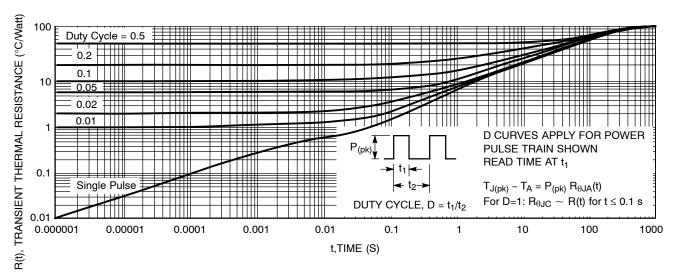


Figure 13. Minimum Pad Transient Thermal Resistance (Non-normalized Junction-to-Ambient)

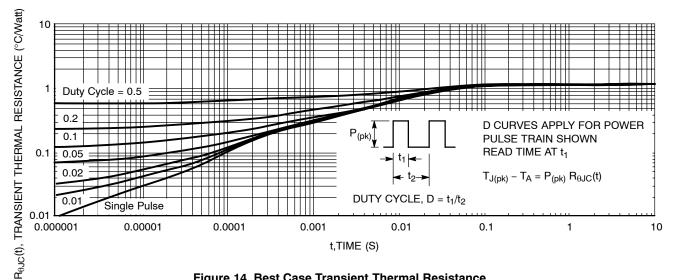
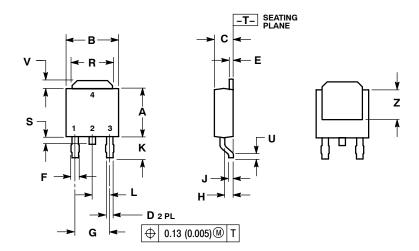


Figure 14. Best Case Transient Thermal Resistance (Non-normalized Junction-to-Case Mounted on Cold Plate)

#### PACKAGE DIMENSIONS

#### **DPAK**

CASE 369C-01 **ISSUE O** 



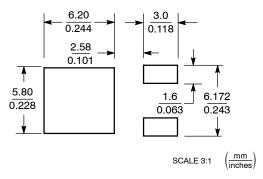
- NOTES:
  1. DIMENSIONING AND TOLERANCING
- PER ANSI Y14.5M, 1982.
  2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.235	0.245	5.97	6.22	
В	0.250	0.265	6.35	6.73	
С	0.086	0.094	2.19	2.38	
D	0.027	0.035	0.69	0.88	
E	0.018	0.023	0.46	0.58	
F	0.037	0.045	0.94	1.14	
G	0.180	BSC	4.58 BSC		
Н	0.034	0.040	0.87	1.01	
J	0.018	0.023	0.46	0.58	
K	0.102	0.114	2.60	2.89	
L	0.090	BSC	2.29	BSC	
R	0.180	0.215	4.57	5.45	
S	0.025	0.040	0.63	1.01	
U	0.020		0.51		
٧	0.035	0.050	0.89	1.27	
Z	0.155		3.93		

#### STYLE 7:

- PIN 1. GATE
  2. COLLECTOR
  3. EMITTER
  4. COLLECTOR

#### **SOLDERING FOOTPRINT\***



\*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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